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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO
09/900,986	07/09/2001	Ramkumar Subramanian	039153-0363 (F0804)	8654
7590 01/10/2005			EXAMINER	
Joseph N. Ziebert			CHEN, JACK S J	
FOLEY & LAR	DNER			
Firstar Center			ART UNIT	PAPER NUMBER
777 East Wisconsin Avenue			2813	
Milwaukee, WI 53202-5367			DATE MAILED: 01/10/2005	

Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)				
	09/900,986	SUBRAMANIAN ET AL.				
Office Action Summary	Examiner	Art Unit				
	Jack Chen	2813				
The MAILING DATE of this communication app Period for Reply	pears on the cover sheet with the c	correspondence address				
A SHORTENED STATUTORY PERIOD FOR REPLY THE MAILING DATE OF THIS COMMUNICATION. - Extensions of time may be available under the provisions of 37 CFR 1.11 after SIX (6) MONTHS from the mailing date of this communication. - If the period for reply specified above is less than thirty (30) days, a reply - If NO period for reply is specified above, the maximum statutory period v - Failure to reply within the set or extended period for reply will, by statute Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	36(a). In no event, however, may a reply be ting within the statutory minimum of thirty (30) day will apply and will expire SIX (6) MONTHS from , cause the application to become ABANDONE	nely filed s will be considered timely. the mailing date of this communication. D (35 U.S.C. § 133).				
Status						
1) Responsive to communication(s) filed on						
	action is non-final.					
3) Since this application is in condition for alloward	3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is					
closed in accordance with the practice under E	x parte Quayle, 1935 C.D. 11, 45	53 O.G. 213.				
Disposition of Claims						
4)⊠ Claim(s) <u>1-4,9-13,15-17 and 19-23</u> is/are pending in the application.						
4a) Of the above claim(s) is/are withdraw	4a) Of the above claim(s) is/are withdrawn from consideration.					
5) Claim(s) is/are allowed.	5) Claim(s) is/are allowed.					
<u> </u>	6)⊠ Claim(s) <u>1-4,9-13,15-17 and 19-23</u> is/are rejected.					
·	<u>, </u>					
8) Claim(s) are subject to restriction and/o	r election requirement.					
Application Papers						
9) ☐ The specification is objected to by the Examine	er.					
10) ☐ The drawing(s) filed on is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.						
Applicant may not request that any objection to the						
Replacement drawing sheet(s) including the correct						
11) ☐ The oath or declaration is objected to by the Ex	tammer. Note the attached Office	Action of form PTO-132.				
Priority under 35 U.S.C. § 119						
 12) ☐ Acknowledgment is made of a claim for foreign a) ☐ All b) ☐ Some * c) ☐ None of: 1. ☐ Certified copies of the priority document)-(d) or (f).				
2. Certified copies of the priority document		ion No.				
3. Copies of the certified copies of the prio						
application from the International Bureau	u (PCT Rule 17.2(a)).					
* See the attached detailed Office action for a list	of the certified copies not receive	ed.				
Attachment(s)						
1) Notice of References Cited (PTO-892)	4) 🔲 Interview Summary	(PTO-413)				
2) Notice of Draftsperson's Patent Drawing Review (PTO-948)	Paper No(s)/Mail Da					
3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date	6) Other:	atent Application (F + O-102)				

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DETAILED ACTION

In response to the communication filed on October 21, 2004, claims 1-4, 9-13, 15-17 and 19-23 are active in this application.

Claim Rejections - 35 USC § 112

- 1. The following is a quotation of the second paragraph of 35 U.S.C. 112:
 - The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.
- 2. Claims 21-23 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.
 - Re claim 21, the phrase "the dielectric layer" lacks antecedent basis.
 - Re claim 22, the phrase "the dielectric layer" lacks antecedent basis.
 - Re claim 23, the phrase "the dielectric layer" lacks antecedent basis.

Claim Rejections - 35 USC § 102

3. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 4. Claims 1-3, 11-13, 15-17 and 19-23 are rejected under 35 U.S.C. 102(b) as being anticipated by Liu, U.S./5,688,704.

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Re claim 1, Liu discloses a method for forming an IC, which comprises providing a gate dielectric layer 29 (fig. 5) above a top surface of a substrate 11; providing a silicon and nitrogen containing layer 17 (i.e., silicon nitride layer) above the gate dielectric layer (fig. 5); providing an oxide layer 19 above the silicon and nitrogen containing layer (fig. 2); selectively etching the oxide layer to form a first trench in the oxide layer (fig. 4); selectively etching the silicon and nitrogen containing layer to form a second trench (fig. 3) in the silicon and nitrogen containing layer, the second trench being narrower than the first trench and being disposed below the first trench (fig. 4); and providing a gate conductor material 31 in the first trench and the second trench to form the T-shaped gate conductor (fig. 5), see figs. 1-7 and cols. 1-4 for more details.

Re claim 11, Liu discloses a method for forming an IC, which comprises providing a first layer 17 above a substrate 11 (fig. 2), the first layer containing silicon and nitrogen (i.e., silicon nitride); providing an oxide layer 19 over the first layer (fig. 2); selectively etching a first trench in the oxide layer by etching (fig. 4); selectively etching a second trench by etching in the first layer (fig. 3), the second trench having a smaller width than the first trench (fig. 4); and providing a gate conductor material 31 in the first trench and in the second trench to form the T-shaped gate conductor (fig. 5), see figs. 1-7 and cols. 1-4 for more details.

Re claim 15, Liu discloses a method for forming an IC, which comprises providing a first layer 17 above a gate dielectric layer 29 (fig. 5), the gate dielectric layer being above a substrate 11 (fig. 5), the first layer including silicon and nitrogen (i.e., silicon nitride); providing a second layer 19 above the first layer (fig. 2); selectively etching a first aperture in the second layer by etching (fig. 4); selectively etching a second aperture in the first layer utilizing an etching process (fig. 3), wherein the second aperture is narrower than the first aperture (fig. 4); filling the

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first aperture and the second aperture with a gate conductor material 31 (fig. 5); and removing the gate conductor material above the second layer, thereby leaving the T-shaped gate conductor in the first and second aperture (fig. 5), see figs. 1-7 and cols. 1-4 for more details.

Re claims 2 and 12, further comprises removing the oxide layer (figs. 5-6).

Re claims 3 and 13, further comprises removing portions of the silicon and nitrogen containing layer, whereby a pair of spacers 33 remain underneath the gate conductor material in the first trench (fig. 7).

Re claim 17, wherein the gate conductor material is doped or undoped polysilicon material (fig. 5, col. 2, line 63).

Re claim 19, wherein the gate conductor material is silicided (col. 3, lines 20-30).

Re claims 21-23, due to 112 problems, as best can be understood by the examiner is as following: the dielectric layer 19 (fig. 2) is silicon dioxide (col. 2, lines 35-40).

Claim Rejections - 35 USC § 103

- 5. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- This application currently names joint inventors. In considering patentability of the claims under 35 U.S.C. 103(a), the examiner presumes that the subject matter of the various claims was commonly owned at the time any inventions covered therein were made absent any evidence to the contrary. Applicant is advised of the obligation under 37 CFR 1.56 to point out

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the inventor and invention dates of each claim that was not commonly owned at the time a later invention was made in order for the examiner to consider the applicability of 35 U.S.C. 103(c) and potential 35 U.S.C. 102(e), (f) or (g) prior art under 35 U.S.C. 103(a).

7. Claims 4, 9-10 are rejected under 35 U.S.C. 103(a) as being unpatentable over Liu, U.S./5,688,704.

Liu disclosed above, however, Liu does not explicitly show the width for the first and second trenches as shown in the instant claims 9-10 and using polishing process as shown in claim 4.

It is well known in the art to use polishing process or etch-back process for planarization since both of them provide the same results. Therefore, it is obvious to one having ordinary skill in the art at the time the invention was made to either one of them.

Furthermore, it would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the method of Liu by selecting the suitable width for the first and second trenches, since it has been held that where the general conditions of a claim are disclosed in the prior art, discovering the optimum or workable ranges involves only routine skill in the art. In re Aller, 220 F.2d 454, 456, 105 USPQ 233, 235 (CCPA 1955).

Response to Arguments

8. Applicant's arguments filed March 3, 2004 have been fully considered but they are not persuasive.

Applicant stated that the instant claims 1 and 15 recites that the silicon and nitrogen containing layer is provided above the gate dielectric layer is noted. The prior art also shows this

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feature (i.e., fig. 5, the silicon nitride layer 17 is provided above the gate dielectric layer 29). Note: this layer (silicon and nitrogen containing layer) does not require to be in direct contact with the gate dielectric layer as shown in the claims. Furthermore, the claims fail to claim the sequential steps for forming the device (i.e., the term "comprising" indicates that the claim is open-ended and allows for additional steps).

Applicant argues that the prior art requires an additional step not required by the instant invention. However, it is noted that the term "comprising" is used (open-end).

Applicant requests the examiner to provide a reference for the instant claim 4 is noted.

For example, Lur et al., U.S./5,981,383 teaches using polishing process or etch-back process for planarization, see col. 7, line 9-22.

Conclusion

9. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event,

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however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Jack Chen whose telephone number is (571)272-1689. The examiner can normally be reached on Monday-Friday (9:00am-6:30pm) alternate Monday off.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Carl W. Whitehead can be reached on (571)272-1702. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Jack Chen

Primary Examiner

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January 5, 2005